

<High Voltage Insulated Gate Bipolar Transistor: HVIGBT >

CM800DZ-34H

HIGH POWER SWITCHING USE
INSULATED TYPE

3rd-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

CM800DZ-34H



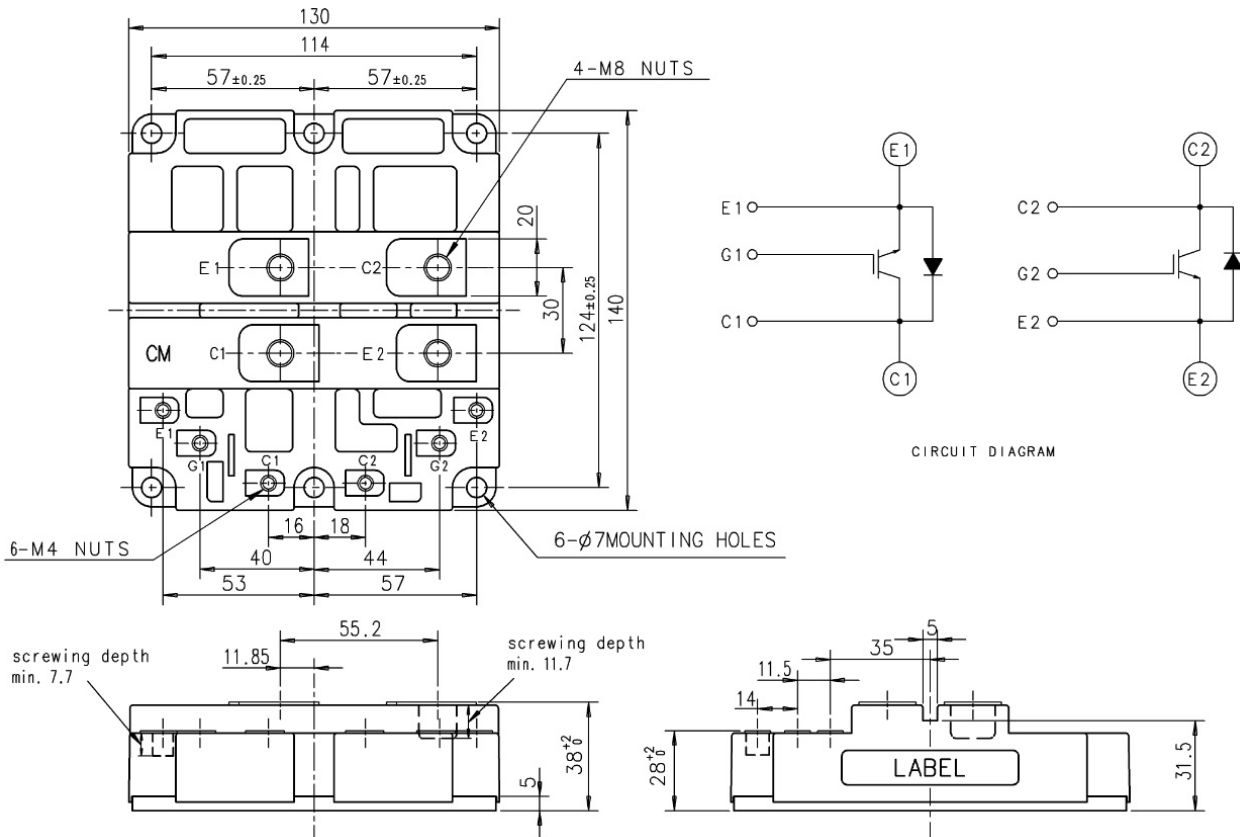
- I_C 800 A
- V_{CES} 1700 V
- 2-element in pack
- High Insulated type
- AISiC baseplate

APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers

OUTLINE DRAWING & CIRCUIT DIAGRAM

Dimensions in mm



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MAXIMUM RATINGS

| Symbol | Item | Conditions | Ratings | Unit |
|-----------|------------------------------------|--|-----------------|------------|
| V_{CES} | Collector-emitter voltage | $V_{GE} = 0V, T_j = 25^\circ C$ | 1700 | V |
| V_{GES} | Gate-emitter voltage | $V_{CE} = 0V, T_j = 25^\circ C$ | ± 20 | V |
| I_C | Collector current | DC, $T_c = 80^\circ C$ | 800 | A |
| I_{CRM} | | Pulse (Note 1) | 1600 | A |
| I_E | Emitter current (Note 2) | DC | 800 | A |
| I_{ERM} | | Pulse (Note 1) | 1600 | A |
| P_{tot} | Maximum power dissipation (Note 3) | $T_c = 25^\circ C$, IGBT part | 6200 | W |
| V_{iso} | Isolation voltage | RMS, sinusoidal, $f = 60Hz, t = 1 \text{ min.}$ | 4000 | V |
| T_j | Junction temperature | | $-40 \sim +150$ | $^\circ C$ |
| T_{jop} | Operating junction temperature | | $-40 \sim +125$ | $^\circ C$ |
| T_{stg} | Storage temperature | | $-40 \sim +125$ | $^\circ C$ |
| t_{psc} | Short circuit pulse width | $V_{CC} = 1150V, V_{CE} \leq V_{CES}, V_{GE} = 15V, T_j = 125^\circ C$ | 10 | μs |

ELECTRICAL CHARACTERISTICS

| Symbol | Item | Conditions | Limits | | | Unit | |
|-----------------|--|---|---------------------|------|------|---------|----|
| | | | Min | Typ | Max | | |
| I_{CES} | Collector cutoff current | $V_{CE} = V_{CES}, V_{GE} = 0V, T_j = 25^\circ C$ | — | — | 12.0 | mA | |
| $V_{GE(th)}$ | Gate-emitter threshold voltage | $V_{CE} = 10V, I_C = 80 \text{ mA}, T_j = 25^\circ C$ | 4.5 | 5.5 | 6.5 | V | |
| I_{GES} | Gate leakage current | $V_{GE} = V_{GES}, V_{CE} = 0V, T_j = 25^\circ C$ | — | — | 0.5 | μA | |
| C_{ies} | Input capacitance | $V_{CE} = 10V, V_{GE} = 0V, f = 100 \text{ kHz}$ $T_j = 25^\circ C$ | — | 72.0 | — | nF | |
| C_{oes} | Output capacitance | | — | 9.0 | — | nF | |
| C_{res} | Reverse transfer capacitance | | — | 3.6 | — | nF | |
| Q_G | Total gate charge | $V_{CC} = 850V, I_C = 800A, V_{GE} = 15V, T_j = 25^\circ C$ | — | 6.6 | — | μC | |
| V_{CESat} | Collector-emitter saturation voltage | $I_C = 800A$ (Note 4) $V_{GE} = 15V$ | $T_j = 25^\circ C$ | — | 2.60 | 3.30 | V |
| | | | $T_j = 125^\circ C$ | — | 3.10 | — | |
| $t_{d(on)}$ | Turn-on delay time | $V_{CC} = 850V, I_C = 800A, V_{GE} = \pm 15V$ $R_{G(on)} = 3.3 \Omega, T_j = 125^\circ C, L_s = 150 \text{ nH}$ | — | — | 1.60 | μs | |
| t_r | Turn-on rise time | | — | — | 1.30 | μs | |
| $E_{on(10\%)}$ | Turn-on switching energy (Note 5) | | Inductive load | — | 350 | — | mJ |
| $t_{d(off)}$ | Turn-off delay time | $V_{CC} = 850V, I_C = 800A, V_{GE} = \pm 15V$ $R_{G(off)} = 3.3 \Omega, T_j = 125^\circ C, L_s = 150 \text{ nH}$ | — | — | 2.70 | μs | |
| t_f | Turn-off fall time | | — | — | 0.50 | μs | |
| $E_{off(10\%)}$ | Turn-off switching energy (Note 5) | | Inductive load | — | 260 | — | mJ |
| V_{EC} | Emitter-collector voltage (Note 2) | $I_E = 800A$ (Note 4) $V_{GE} = 0V$ | $T_j = 25^\circ C$ | — | 2.30 | — | V |
| | | | $T_j = 125^\circ C$ | — | 2.00 | — | |
| t_{rr} | Reverse recovery time (Note 2) | $V_{CC} = 850V, I_C = 800A, V_{GE} = \pm 15V$ $R_{G(on)} = 3.3 \Omega, T_j = 125^\circ C, L_s = 150 \text{ nH}$ | — | — | 2.70 | μs | |
| Q_{rr} | Reverse recovery charge (Note 2) | | — | 300 | — | μC | |
| $E_{rec(10\%)}$ | Reverse recovery energy (Note 2), (Note 5) | | Inductive load | — | 120 | — | mJ |

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THERMAL CHARACTERISTICS

| Symbol | Item | Conditions | Limits | | | Unit |
|----------------|----------------------------|---|--------|------|------|------|
| | | | Min | Typ | Max | |
| $R_{th(i-c)Q}$ | Thermal resistance | Junction to Case, IGBT part, 1/2 module | — | — | 20.0 | K/kW |
| $R_{th(i-c)D}$ | | Junction to Case, FWDi part, 1/2 module | — | — | 34.0 | K/kW |
| $R_{th(c-s)}$ | Contact thermal resistance | Case to heat sink, $\lambda_{grease} = 1W/m^2 \cdot k$, $D_{(c-s)} = 100\mu m$ 1/2 module | — | 16.0 | — | K/kW |

MECHANICAL CHARACTERISTICS

| Symbol | Item | Conditions | Limits | | | Unit |
|-------------|----------------------------|---|--------|------|------|------|
| | | | Min | Typ | Max | |
| M_t | Mounting torque | M8 : Main terminals screw | 7.0 | — | 13.0 | N·m |
| M_s | | M6 : Mounting screw | 3.0 | — | 6.0 | N·m |
| M_t | | M4 : Auxiliary terminals screw | 1.0 | — | 2.0 | N·m |
| m | Mass | | — | 1.0 | — | kg |
| CTI | Comparative tracking index | | 250 | — | — | — |
| d_a | Clearance | | 10.0 | — | — | mm |
| d_s | Creepage distance | | 15.0 | — | — | mm |
| L_{PCE} | Parasitic stray inductance | IGBT part, 1/2 module | — | 18 | — | nH |
| R_{CC+EE} | Internal lead resistance | IGBT part, 1/2 module, $T_C = 25^\circ C$ | — | 0.16 | — | mΩ |

Note 1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed T_{jopmax} rating.

Note 2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD).

Note 3. Junction temperature (T_j) should not exceed T_{jmax} rating (150°C).

Note 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

Note 5. $E_{on(10\%)} / E_{off(10\%)} / E_{rec(10\%)}$ are the integral of $0.1V_{CE} \times 0.1I_C \times dt$.

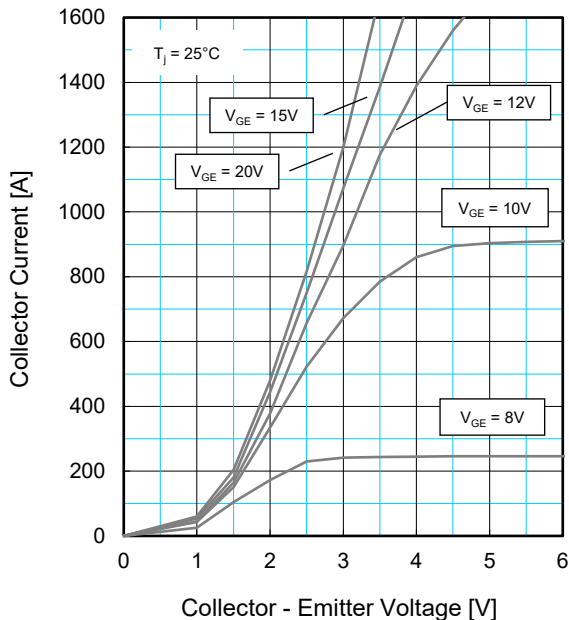
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HIGH POWER SWITCHING USE
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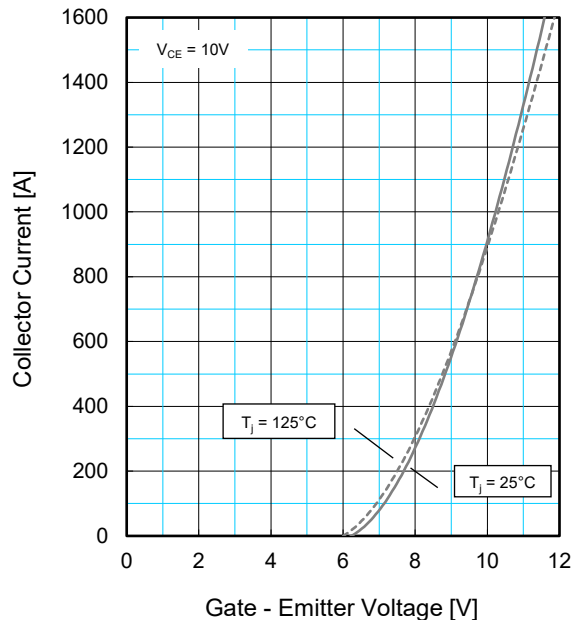
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PERFORMANCE CURVES

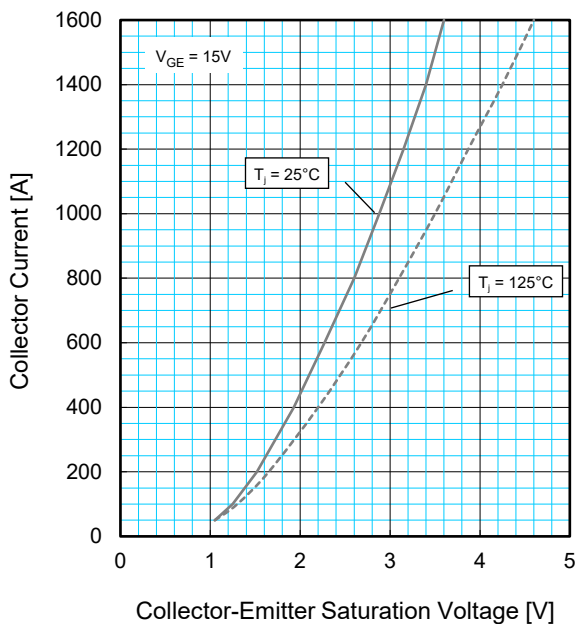
OUTPUT CHARACTERISTICS (TYPICAL)



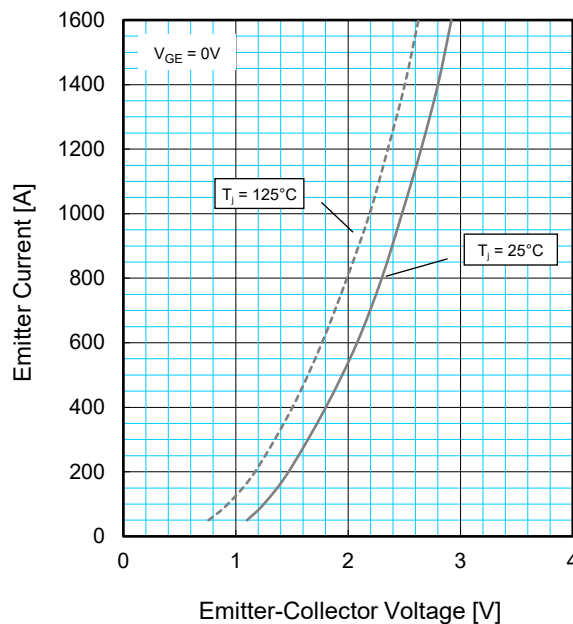
TRANSFER CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)



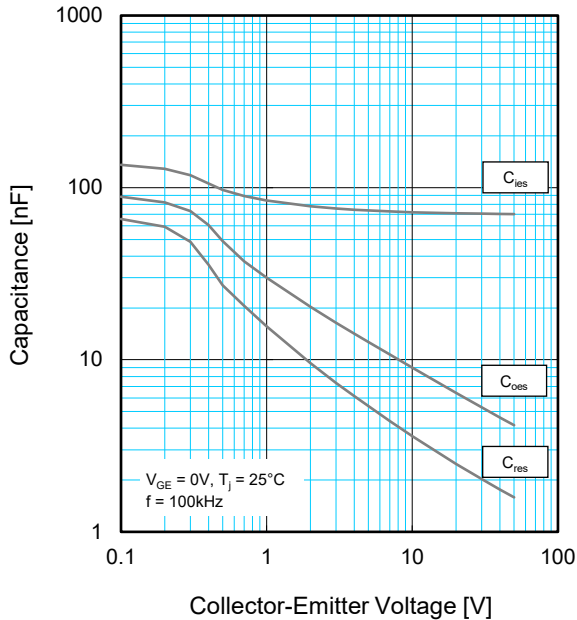
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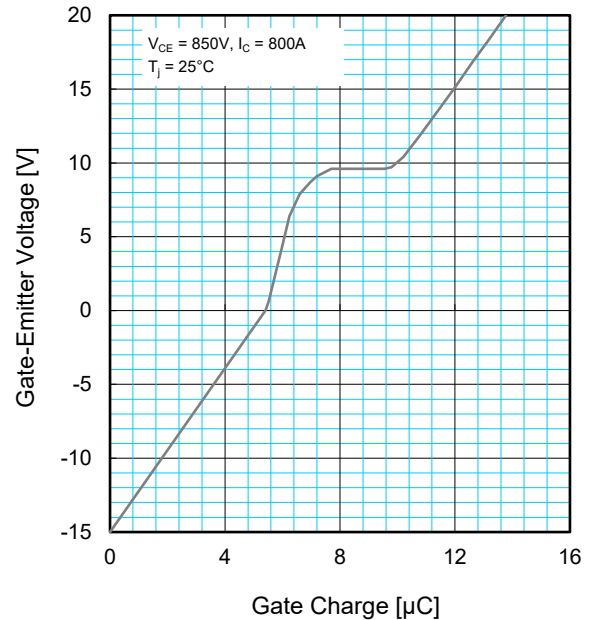
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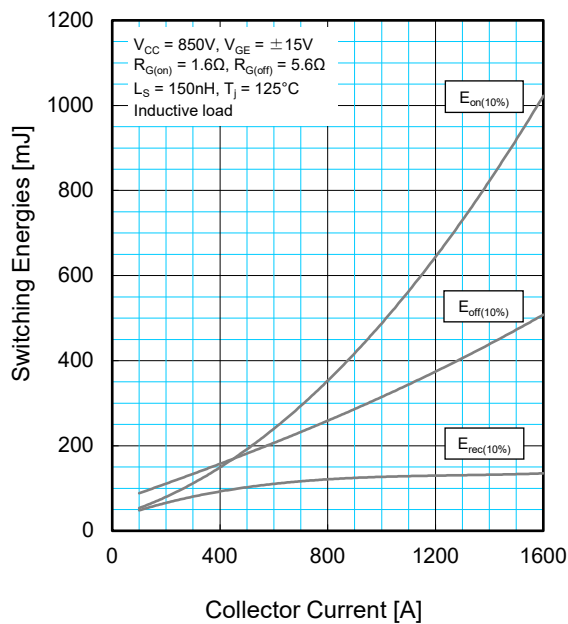
CAPACITANCE CHARACTERISTICS (TYPICAL)



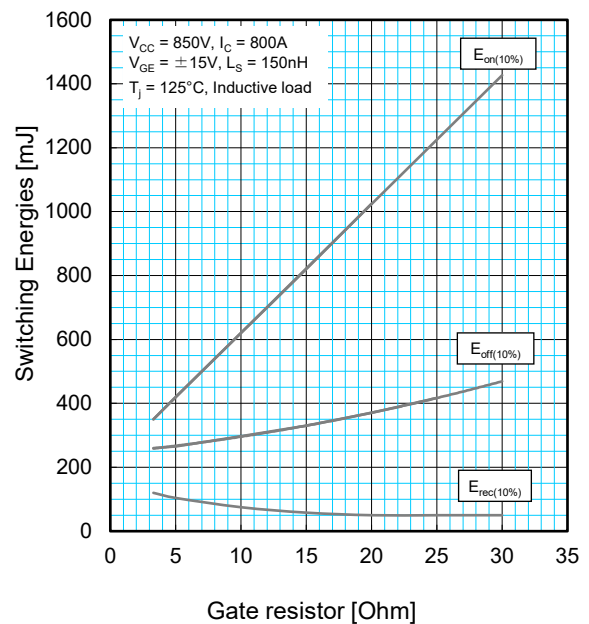
GATE CHARGE CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



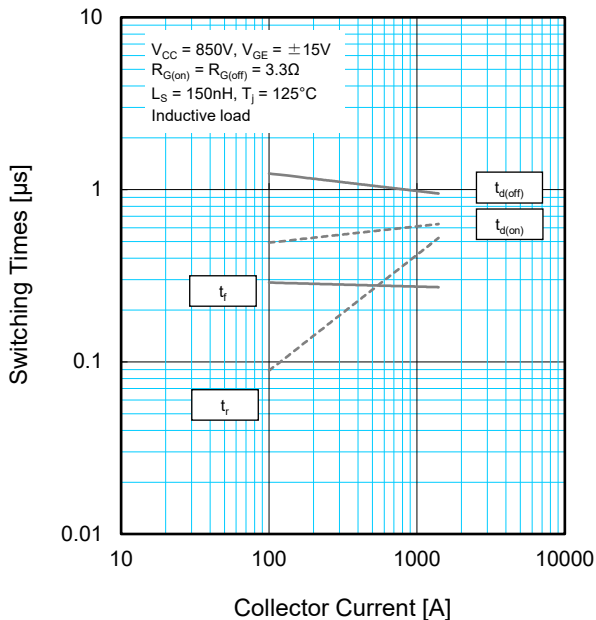
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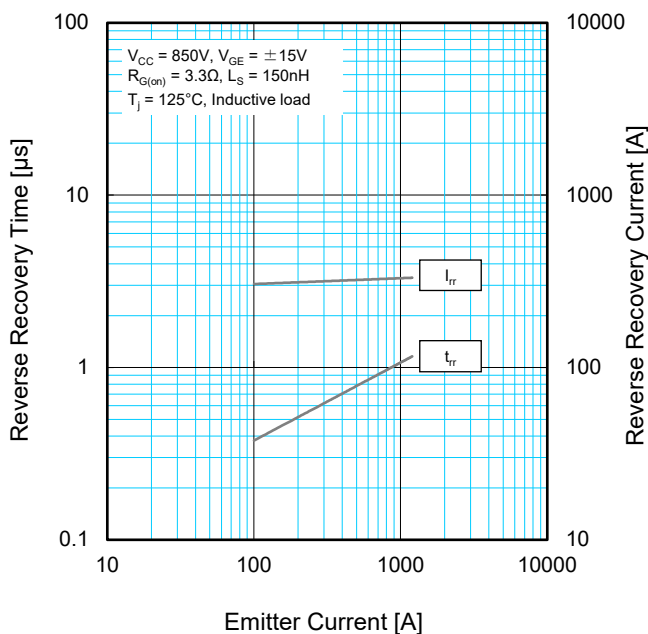
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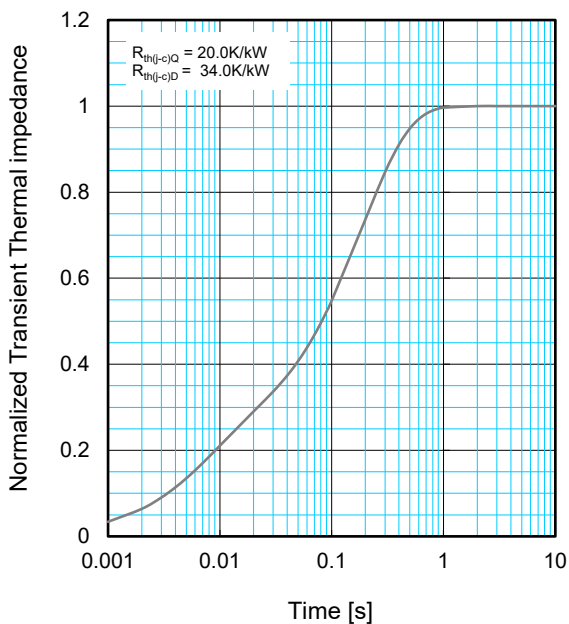
HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i \left\{ 1 - \exp\left(-\frac{t}{\tau_i}\right) \right\}$$

| | 1 | 2 | 3 | 4 |
|----------------|-------|------|-------|-------|
| R_i [K/kW] | 0.07 | 0.11 | 0.45 | 0.37 |
| τ_i [sec] | 0.001 | 0.01 | 0.077 | 0.432 |

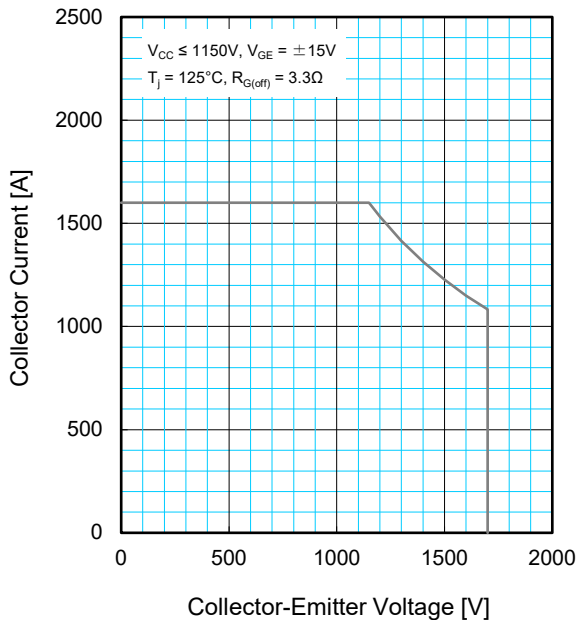
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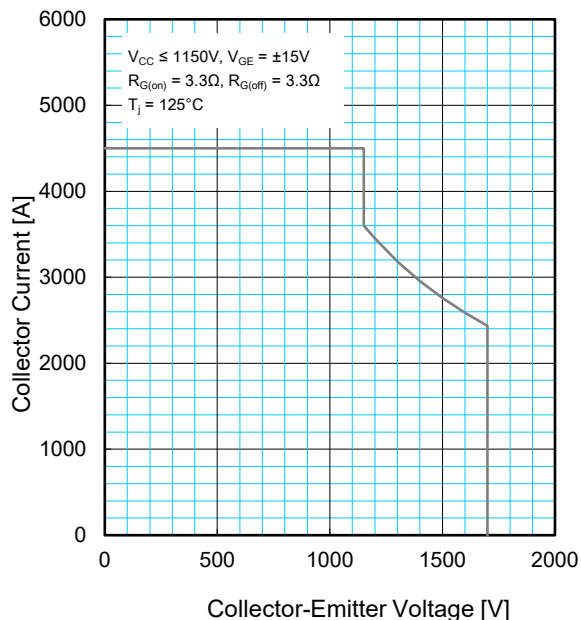
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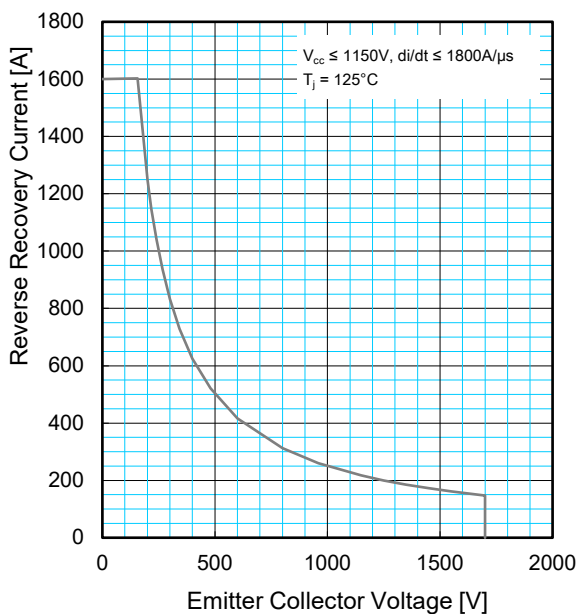
REVERSE BIAS SAFE OPERATING AREA (RBSOA)



SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



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